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Application/Control No.	Applicant(s)/Patent under Reexamination		
09/469,726	WANG, XIN		
Examiner	Art Unit		
LEYNNA T. HA	2135		

	SEARCHED			
Class	Subclass	Date	Examiner	
380	228, 268, 277-278, 281-285,	10/27/2005	US	
380	28-30	10/27/2005	ill	
726	2-5,26-30	10/27/2005	LIK	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		10/27/2005	Ut
NPL PAGES IEEE PROQUEST		14/05	UP